

Product Overview

The QPD1018 is a 500 W (P_{3dB}) internally matched discrete GaN on SiC HEMT which operates from 2.7 to 3.1 GHz on a 50V supply rail. The device is GaN IMFET fully matched to 50 Ω in an industry standard air cavity package and is ideally suited for military radar.

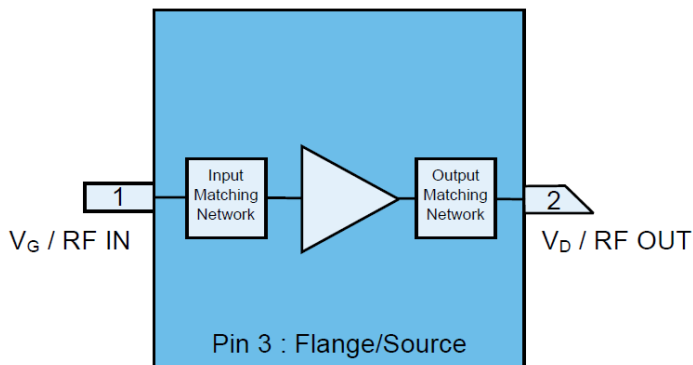
ROHS compliant.

Evaluation boards are available upon request.



17.40 x 24.00 x 4.31 mm

Functional Block Diagram



Key Features¹

- Frequency: 2.7 to 3.1 GHz
- Output Power (P_{3dB})¹: 575 W
- Linear Gain¹: 17.7 dB
- Typical PAE_{3dB} ¹: 67.9%
- Operating Voltage: 50 V
- Low thermal resistance package
- Pulse capable

Note 1: @ 2.9 GHz

Applications

- Military radar
- Civilian radar
- Test instrumentation

Ordering Information

| Part No. | Description |
|------------|--------------------|
| QPD1018 | Tray of 18 QPD1018 |
| QPD1018S2 | Pack of 2 QPD1018 |
| QPD1018EVB | 2.7 – 3.1 GHz EVB |

Absolute Maximum Ratings¹

| Parameter | Rating | Units |
|--|-------------|------------------|
| Breakdown Voltage, BV_{DG} | +145 | V |
| Gate Voltage Range, V_G | -7 to +2 | V |
| Drain Current | 20 | A |
| Gate Current Range, I_G | See page 4. | mA |
| Power Dissipation, 10% DC 100 uS PW, P_D , $T = 85^\circ\text{C}$ | 522 | W |
| RF Input Power, 10% DC 100 uS PW, 2.9 GHz, $T = 25^\circ\text{C}$ | +49 | dBm |
| Mounting Temperature (30 Seconds) | 320 | $^\circ\text{C}$ |
| Storage Temperature | -65 to +150 | $^\circ\text{C}$ |

Notes:

1. Operation of this device outside the parameter ranges given above may cause permanent damage.

Recommended Operating Conditions^{1, 2, 3, 4}

| Parameter | Min | Typ | Max | Units |
|--|-----|------|-----|------------------|
| Operating Temp. Range | -40 | +25 | +85 | $^\circ\text{C}$ |
| Drain Voltage Range, V_D | +28 | +50 | +55 | V |
| Drain Bias Current, I_{DQ} | – | 750 | – | mA |
| Drain Current, I_D | – | 15 | – | A |
| Gate Voltage, V_G ⁴ | – | -2.8 | – | V |
| Power Dissipation, Pulsed (P_D) ^{2, 3} | – | – | 472 | W |

Notes:

1. Electrical performance is measured under conditions noted in the electrical specifications table. Specifications are not guaranteed over all recommended operating conditions.
2. Package base at 85°C
3. Pulse Width = 100 uS, Duty Cycle = 10%
4. To be adjusted to desired I_{DQ}

Pulsed Characterization – Load-Pull Performance – Power Tuned¹

| Parameters | Typical Values | | | Unit |
|---|----------------|------|------|------|
| Frequency, F | 2.7 | 2.9 | 3.1 | GHz |
| Linear Gain, G_{LIN} | 16.1 | 16.4 | 14.6 | dB |
| Output Power at 3dB compression point, P_{3dB} | 57.7 | 57.6 | 57.5 | dBm |
| Power-Added-Efficiency at 3dB compression point, PAE_{3dB} | 59.1 | 56.6 | 56.1 | % |
| Gain at 3dB compression point | 13.1 | 13.4 | 11.6 | dB |

Notes:

1. Test conditions unless otherwise noted: $V_D = 50\text{ V}$, $I_{DQ} = 750\text{ mA}$, $\text{Temp} = 25^\circ\text{C}$, 100 uS PW, 10% DC

Pulsed Characterization – Load-Pull Performance – Efficiency Tuned¹

| Parameters | Typical Values | | | Unit |
|---|----------------|------|------|------|
| Frequency, F | 2.7 | 2.9 | 3.1 | GHz |
| Linear Gain, G_{LIN} | 16.9 | 17.7 | 15.8 | dB |
| Output Power at 3dB compression point, P_{3dB} | 56.5 | 56.1 | 55.8 | dBm |
| Power-Added-Efficiency at 3dB compression point, PAE_{3dB} | 68.6 | 67.9 | 65.2 | % |
| Gain at 3dB compression point, G_{3dB} | 13.9 | 14.7 | 12.8 | dB |

Notes:

1. Test conditions unless otherwise noted: $V_D = 50\text{ V}$, $I_{DQ} = 750\text{ mA}$, $\text{Temp} = 25^\circ\text{C}$, 100 uS PW, 10% DC

RF Characterization – 2.7 – 3.1 GHz EVB Performance At 2.7 GHz¹

| Parameter | Min | Typ | Max | Units |
|--|-----|------|-----|-------|
| Linear Gain, G_{LIN} | – | 16.6 | – | dB |
| Output Power at 3dB compression point, P_{3dB} | – | 56.7 | – | dBm |
| Power-Added Efficiency at 3dB compression point, PAE_{3dB} | – | 64.4 | – | % |
| Gain at 3dB compression point, G_{3dB} | – | 13.6 | – | dB |

Notes:

1. $V_D = 50$ V, $I_{DQ} = 750$ mA, Temp = 25°C, 100 uS PW, 10% DC

RF Characterization – 2.7 – 3.1 GHz EVB Performance At 2.9 GHz¹

| Parameter | Min | Typ | Max | Units |
|--|-----|------|-----|-------|
| Linear Gain, G_{LIN} | – | 16.8 | – | dB |
| Output Power at 3dB compression point, P_{3dB} | – | 56.6 | – | dBm |
| Power-Added Efficiency at 3dB compression point, PAE_{3dB} | – | 57.1 | – | % |
| Gain at 3dB compression point, G_{3dB} | – | 13.8 | – | dB |

Notes:

1. $V_D = 50$ V, $I_{DQ} = 750$ mA, Temp = 25°C, 100 uS PW, 10% DC

RF Characterization – 2.7 – 3.1 GHz EVB Performance At 3.1 GHz¹

| Parameter | Min | Typ | Max | Units |
|--|-----|------|-----|-------|
| Linear Gain, G_{LIN} | – | 15.4 | – | dB |
| Output Power at 3dB compression point, P_{3dB} | – | 56.8 | – | dBm |
| Power-Added Efficiency at 3dB compression point, PAE_{3dB} | – | 56.0 | – | % |
| Gain at 3dB compression point, G_{3dB} | – | 12.4 | – | dB |

Notes:

1. $V_D = 50$ V, $I_{DQ} = 750$ mA, Temp = 25°C, 100 uS PW, 10% DC

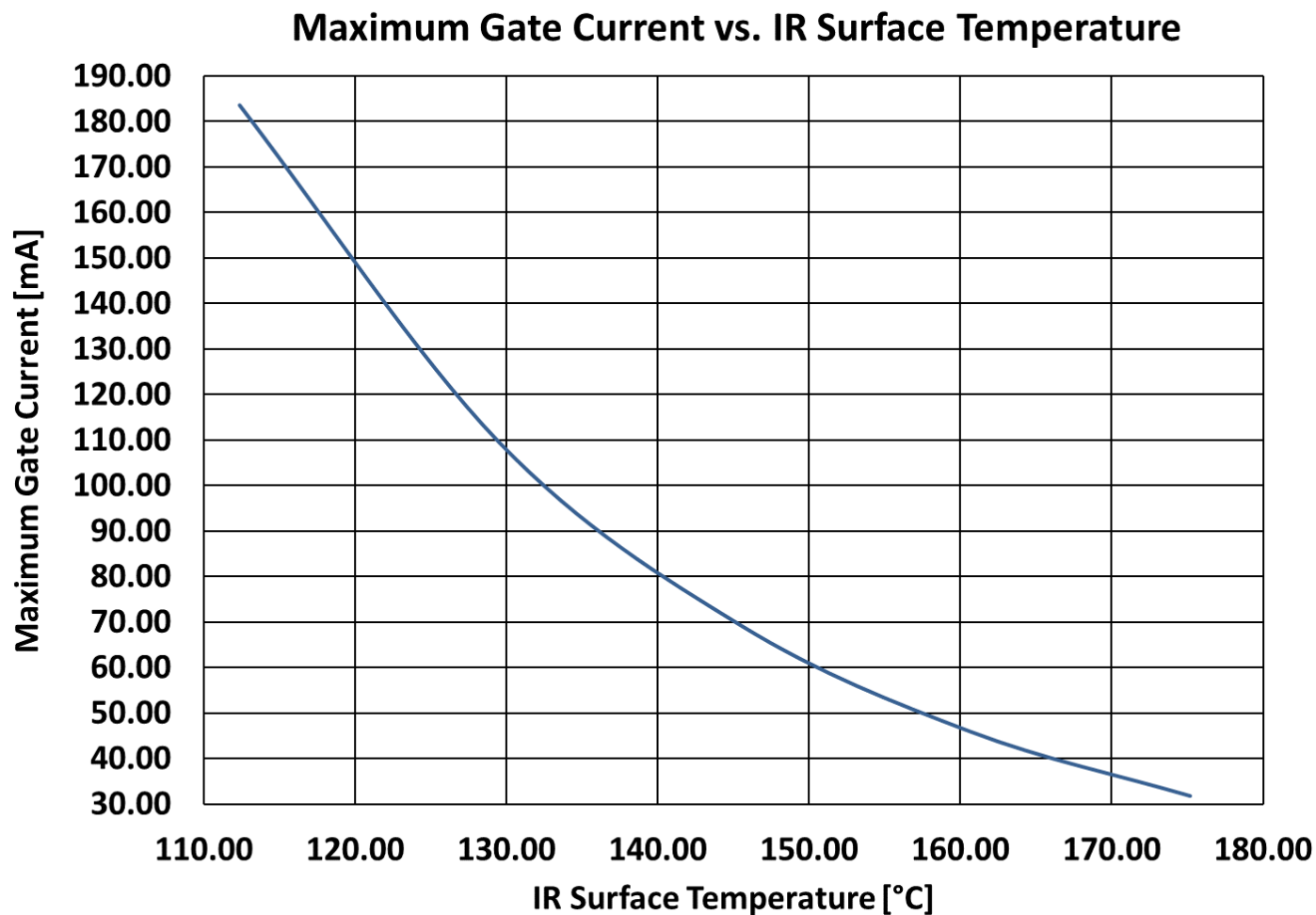
RF Characterization – Mismatch Ruggedness at 2.9 GHz^{1, 2, 3}

| Symbol | Parameter | dB Compression | Typical |
|--------|-------------------------------|----------------|---------|
| VSWR | Impedance Mismatch Ruggedness | 3 | 10:1 |

Notes:

1. Test conditions unless otherwise noted: $T_A = 25^\circ\text{C}$, $V_D = 50$ V, $I_{DQ} = 750$ mA, 100 uS PW, 10% DC.
2. Driving input power is determined at pulsed compression under matched condition at EVB output connector.
3. No spur detected down to the noise floor of Spectrum Analyzer from 1 – 15GHz at $T_A = -40^\circ\text{C}$.

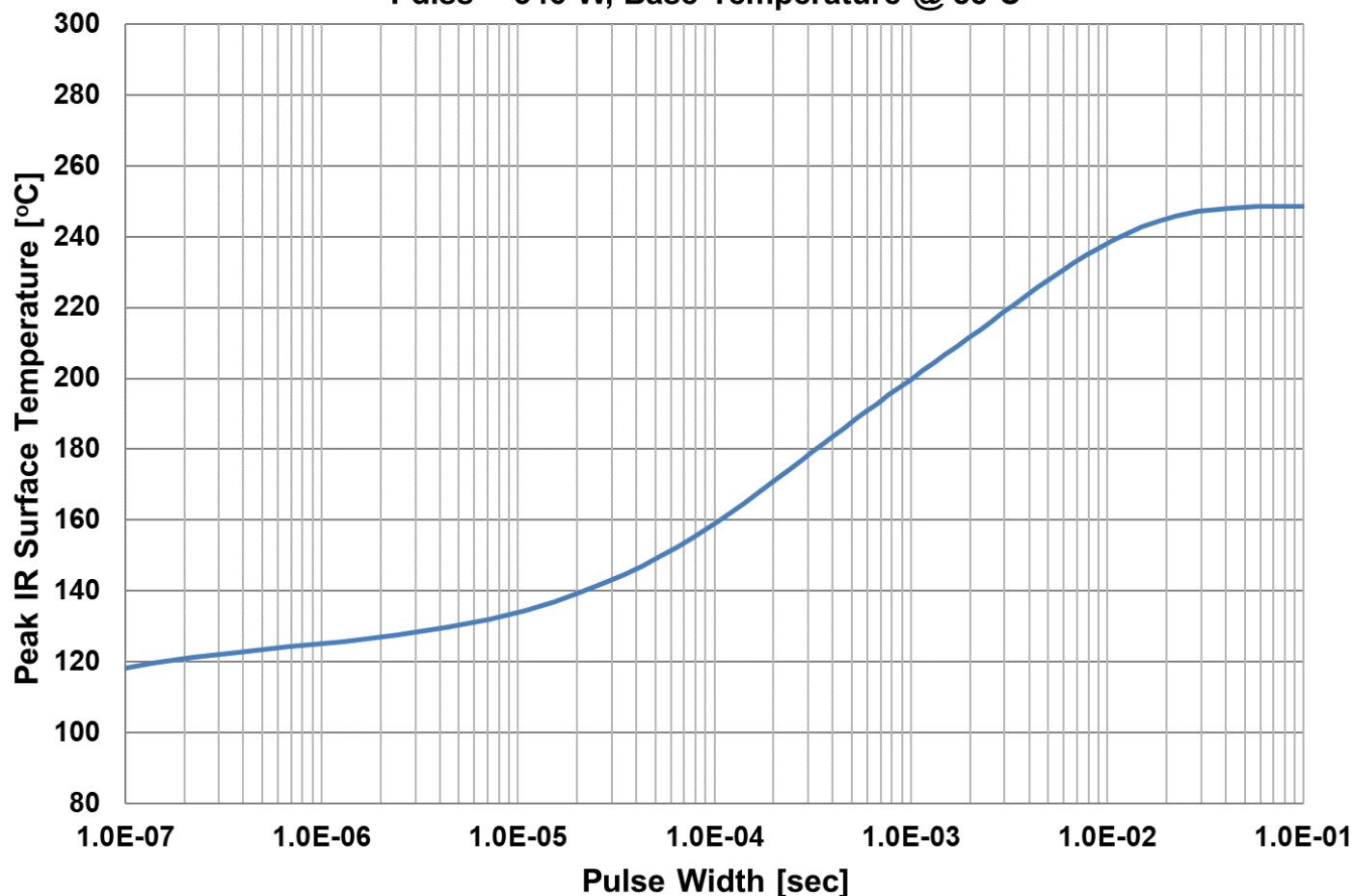
Maximum Gate Current



Thermal and Reliability Information – Pulsed¹

Peak IR Surface Temperature vs. Pulse Width

$P_{diss} = 346\text{ W}$, Base Temperature @ 85°C



| Parameter | Conditions | Values | Units |
|---|------------------------------------|--------|-------|
| Thermal Resistance, IR ¹ (θ_{JC}) | 85°C back side temperature | 0.33 | °C/W |
| Peak IR Surface Temperature ¹ (T_{CH}) | 346 W P_{diss} , 1 mS PW, 10% DC | 200 | °C |

Notes:

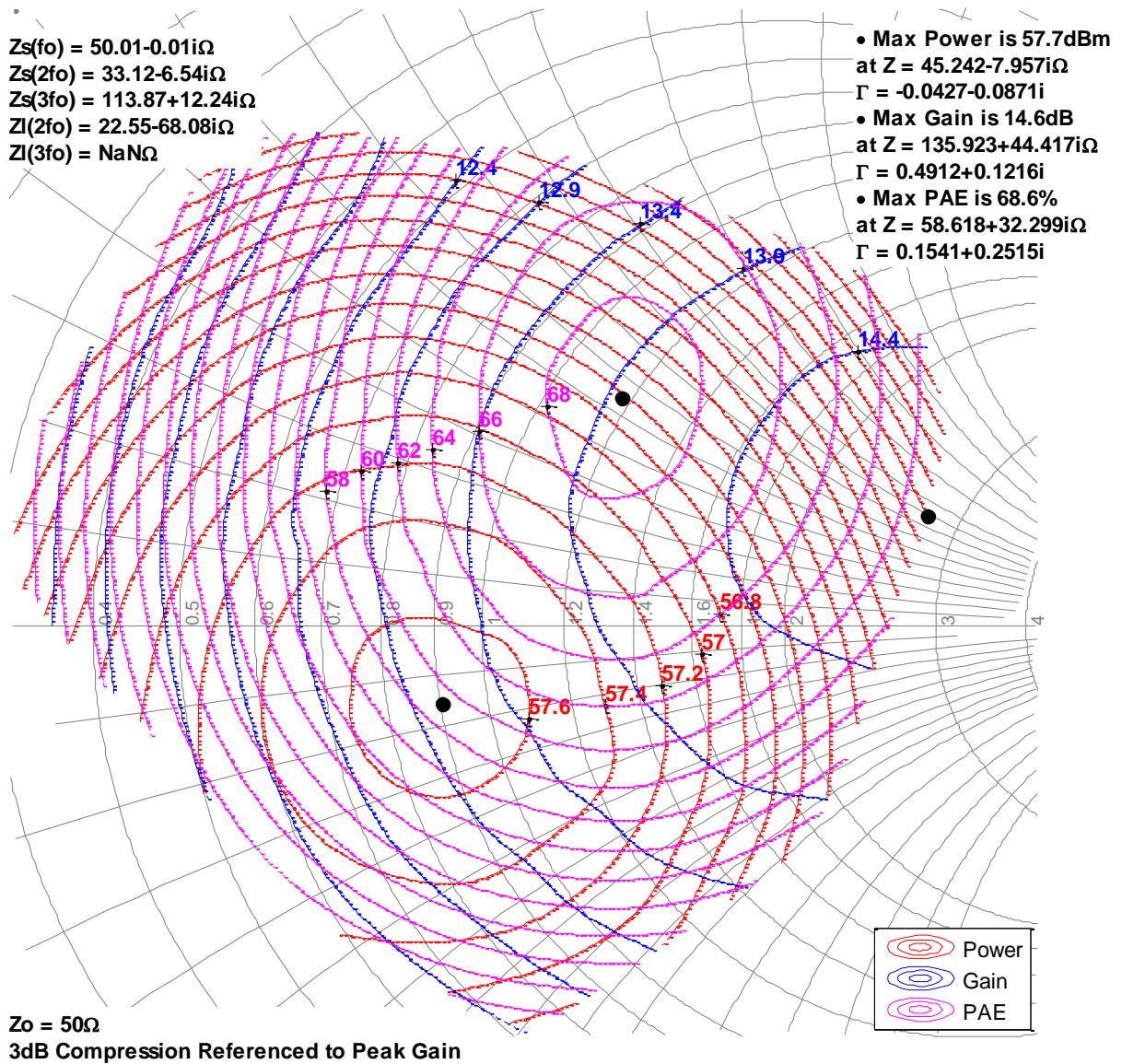
1- Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

Load-Pull Smith Charts^{1, 2, 3}

Notes:

1. $V_D = 50$ V, $I_{DQ} = 750$ mA, 100 μ S PW, 10% DC pulsed. Performance is at 3dB gain compression referenced to peak gain.
2. See page 12 for load-pull and source-pull reference planes. 50- Ω load-pull TRL fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load-pull system.

2.7GHz, Load-pull

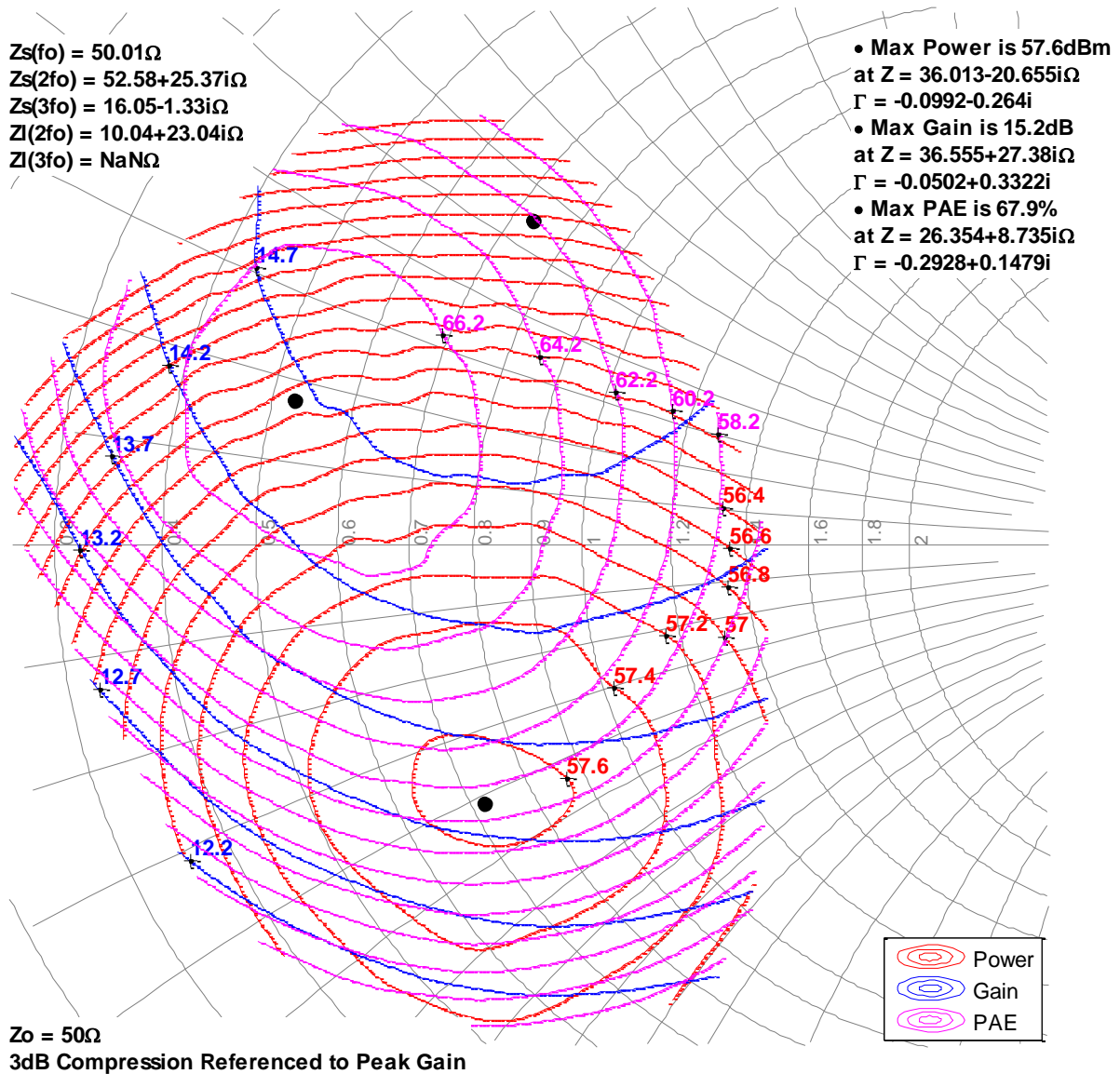


Load-Pull Smith Charts^{1, 2, 3}

Notes:

1. $V_D = 50\text{ V}$, $I_{DQ} = 750\text{ mA}$, 100 uS PW , 10% DC pulsed. Performance is at 3dB gain compression referenced to peak gain.
2. See page 12 for load-pull and source-pull reference planes. $50\text{-}\Omega$ load-pull TRL fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load-pull system.

2.9GHz, Load-pull



Load-Pull Smith Charts^{1, 2, 3}

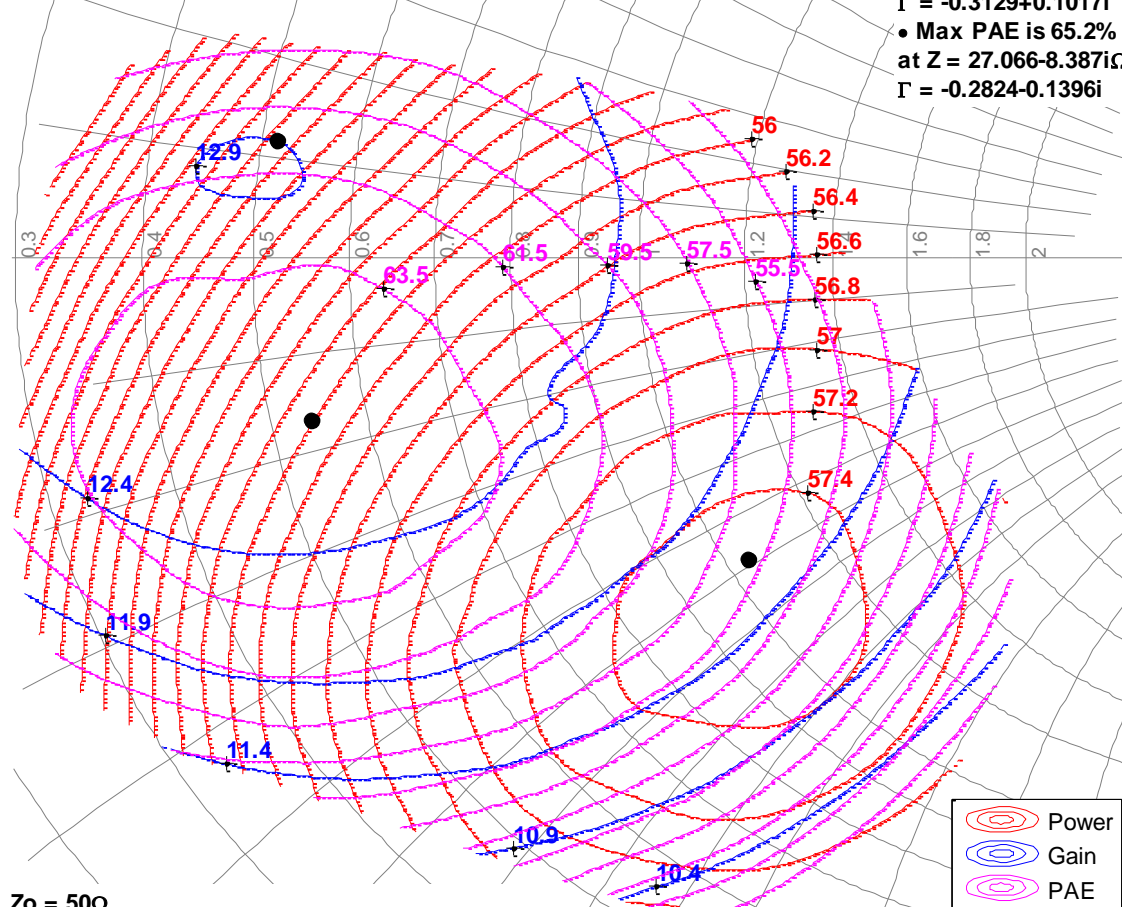
Notes:

1. $V_D = 50$ V, $I_{DQ} = 750$ mA, 100 μ S PW, 10% DC pulsed. Performance is at 3dB gain compression referenced to peak gain.
2. See page 12 for load-pull and source-pull reference planes. 50- Ω load-pull TRL fixtures are built with 20-mil RO4350B material.
3. NaN means the impedances are either undefined or varying in load-pull system.

3.1GHz, Load-pull

$Z_s(f_0) = 49.99 + 0.01i\Omega$
 $Z_s(2f_0) = 68.83 - 20.58i\Omega$
 $Z_s(3f_0) = 245.31 - 140.94i\Omega$
 $Z_l(2f_0) = 123.01 + 32.14i\Omega$
 $Z_l(3f_0) = \text{NaN}\Omega$

- Max Power is 57.5dBm at $Z = 51.87 - 29.303i\Omega$
 $\Gamma = 0.0934 - 0.2608i$
- Max Gain is 12.9dB at $Z = 25.713 + 5.863i\Omega$
 $\Gamma = -0.3129 + 0.1017i$
- Max PAE is 65.2% at $Z = 27.066 - 8.387i\Omega$
 $\Gamma = -0.2824 - 0.1396i$

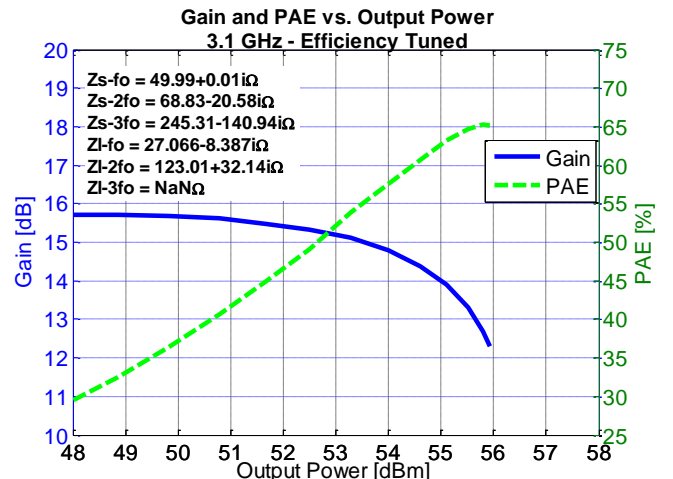
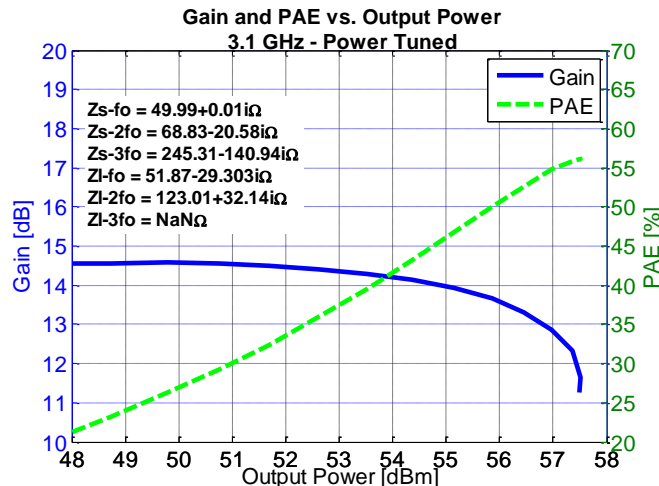
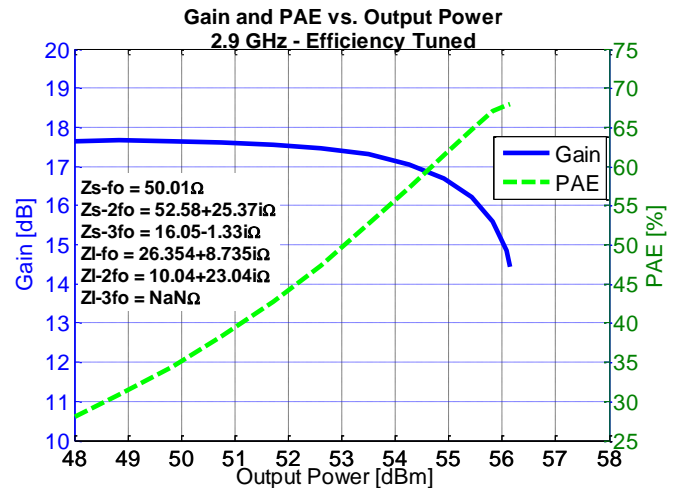
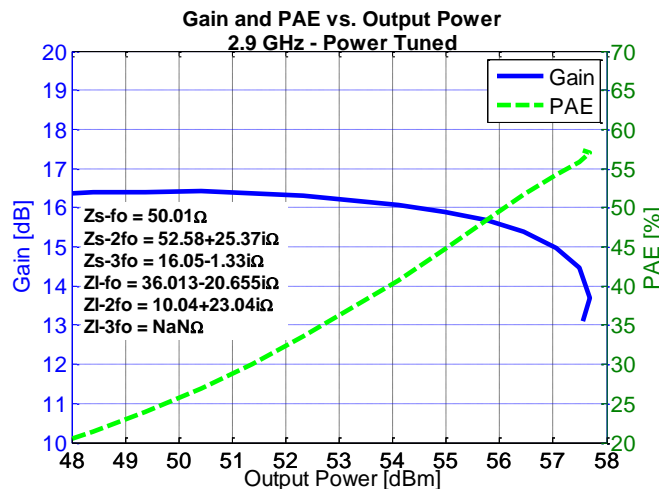
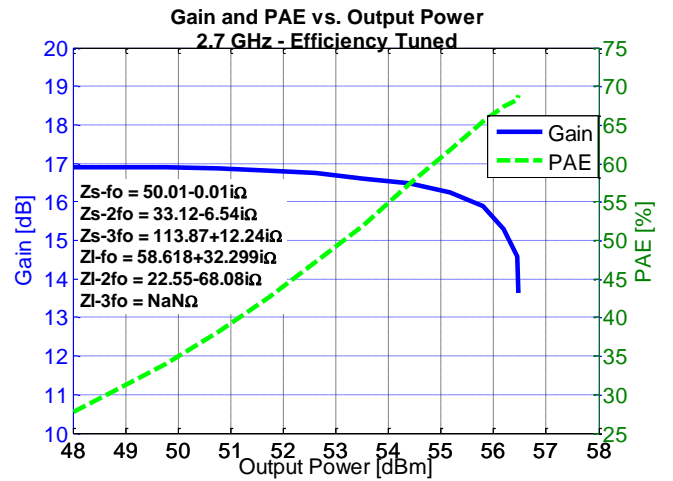
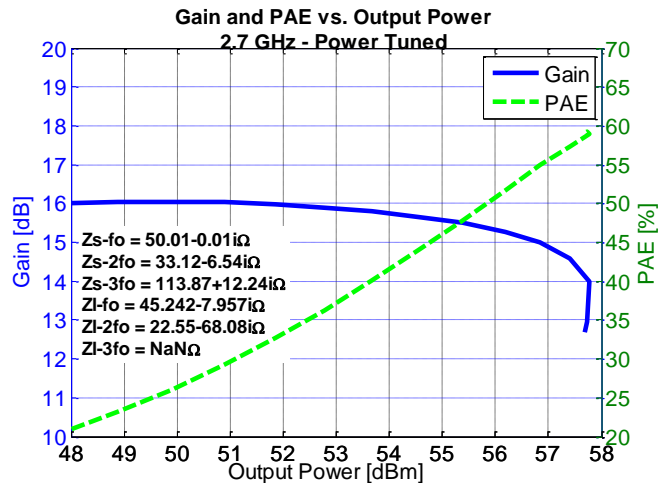


$Z_0 = 50\Omega$
 3dB Compression Referenced to Peak Gain

Typical Performance – Load-Pull Drive-up^{1, 2}

Notes:

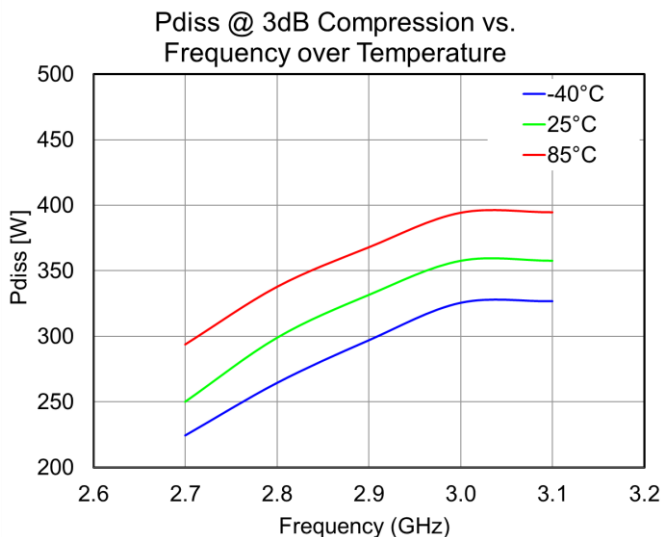
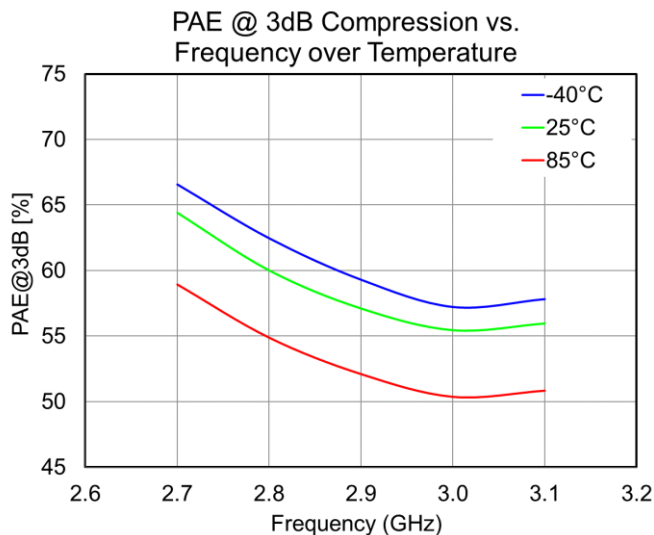
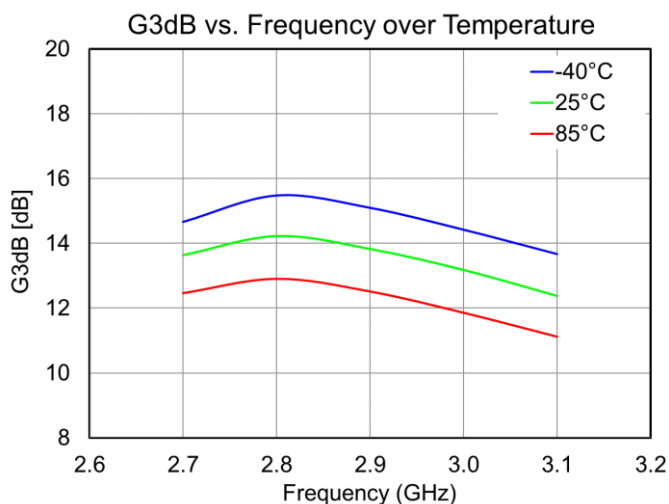
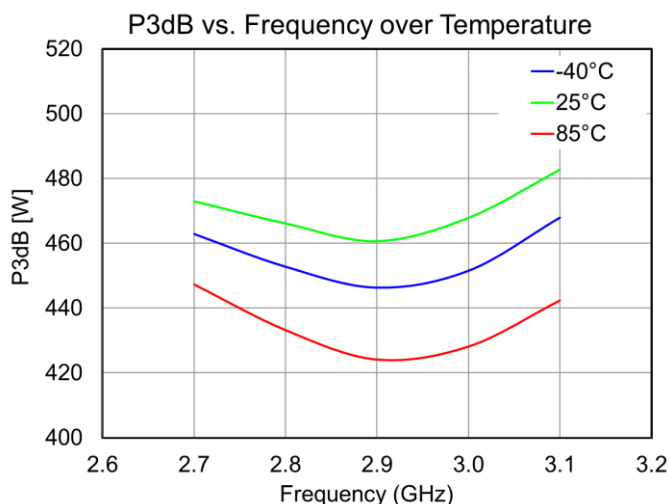
1. 100 μ S PW, 10% DC pulsed signal, $V_D = 50$ V, $I_{DQ} = 750$ mA, $T_A = 25^\circ\text{C}$.
2. See page 12 for load-pull and source-pull reference planes where the performance was measured.



Power Drive-up Performance Over Temperatures Of 2.7 – 3.1 GHz EVB^{1, 2}

Notes:

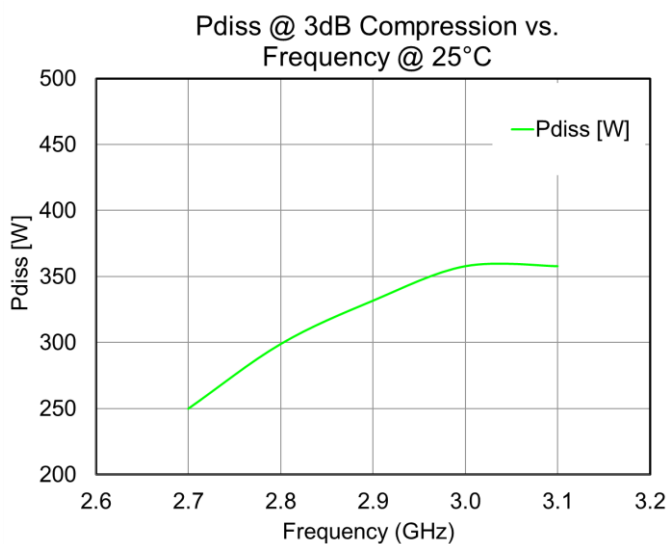
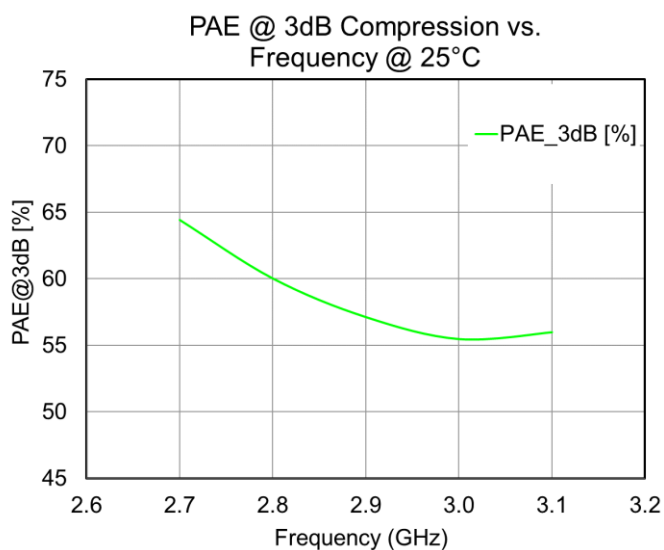
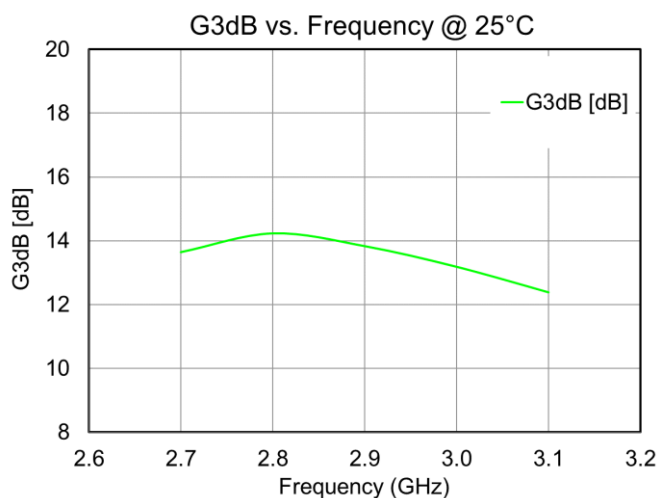
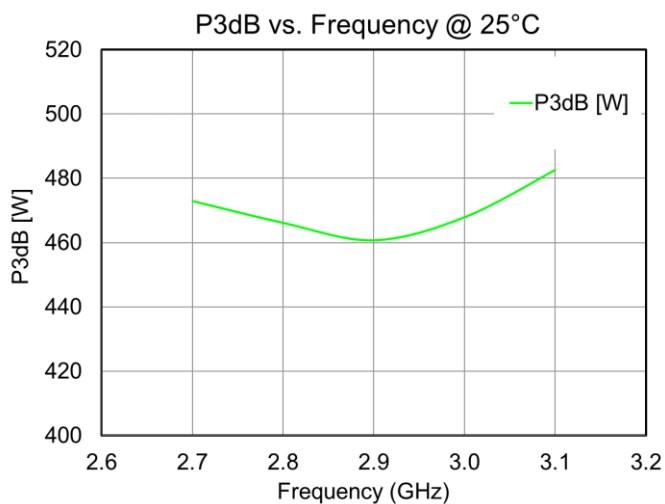
1. $V_D = 50\text{ V}$, $I_{DQ} = 750\text{ mA}$, $100\text{ }\mu\text{S PW}$, $10\%\text{ DC}$.
2. Performance shown is at EVB connectors reference plane.



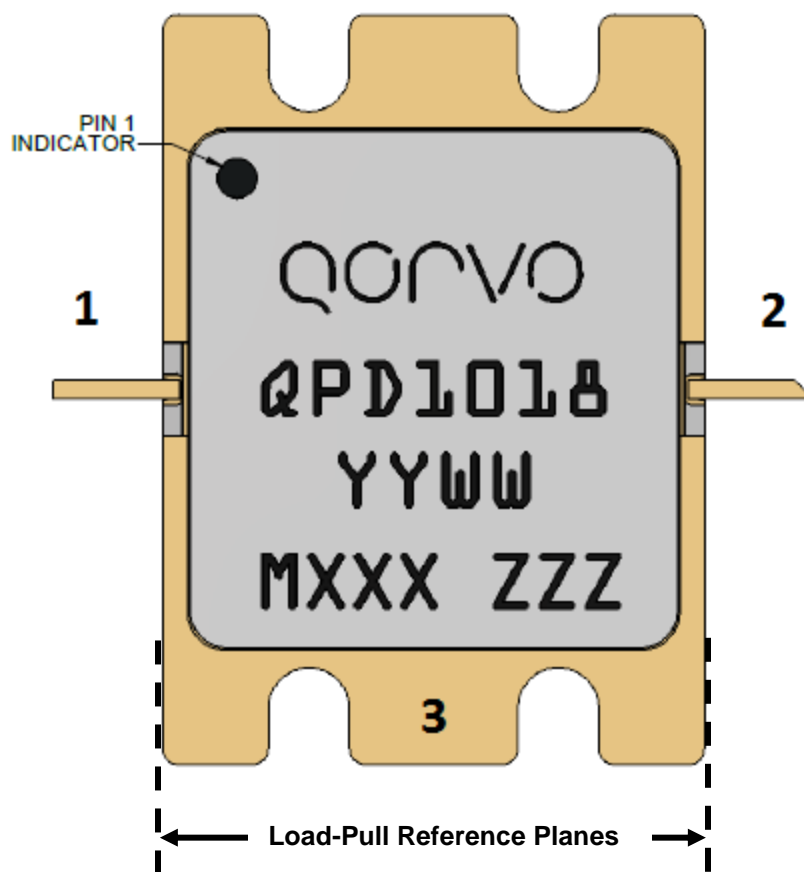
Power Drive-up Performance At 25°C Of 2.7 – 3.1 GHz EVB^{1,2}

Notes:

1. $V_D = 50\text{ V}$, $I_{DQ} = 750\text{ mA}$, $100\text{ }\mu\text{S PW}$, $10\%\text{ DC}$, $T_A = 25^\circ\text{C}$.
2. Performance shown is at EVB connectors reference plane.



Pin Configuration, Marking and Description¹



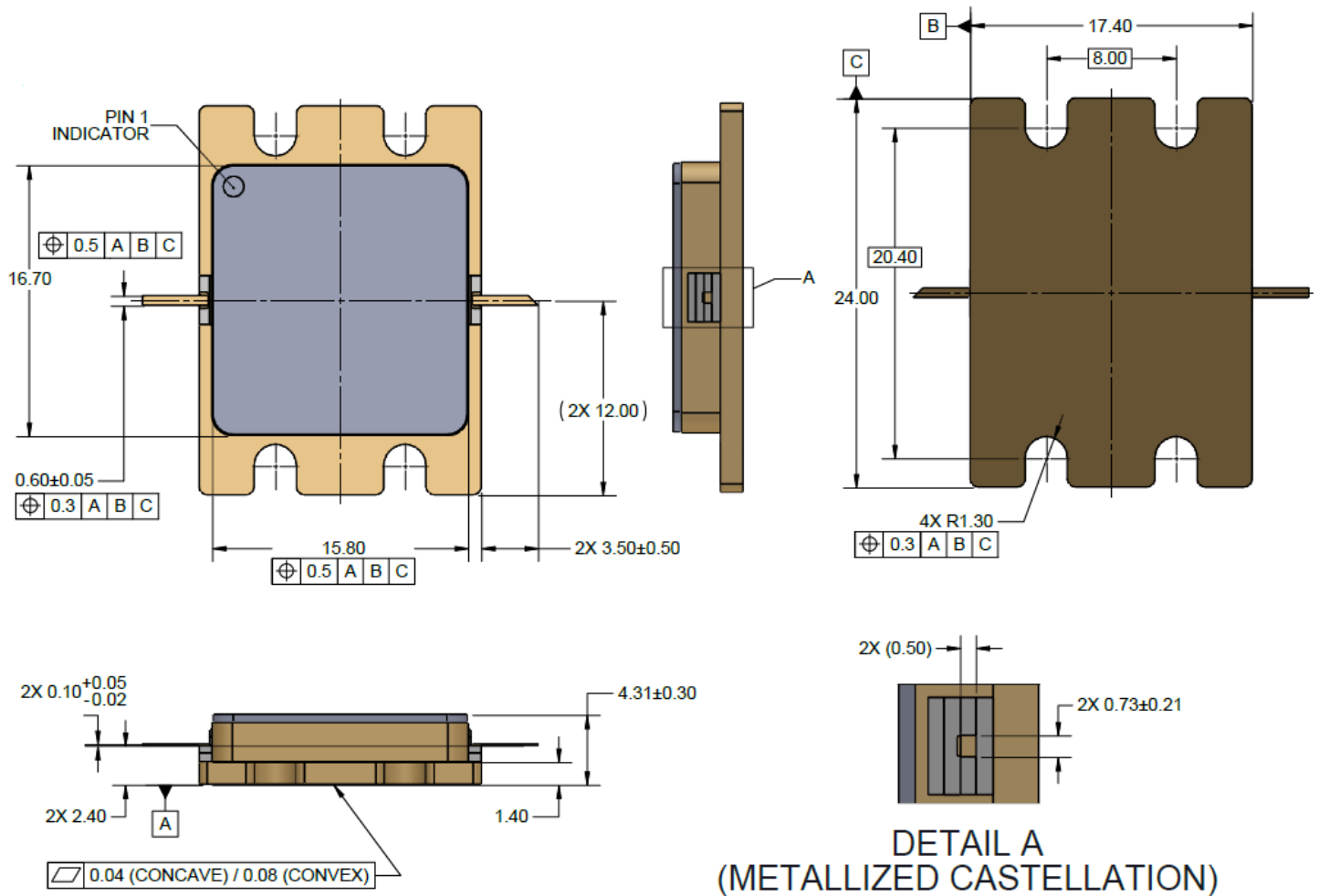
Pin Description

| Pin | Symbol | Description |
|-----|----------------|---------------------------|
| 1 | V_G / RF IN | Gate voltage / RF Input |
| 2 | V_D / RF OUT | Drain voltage / RF Output |
| 3 | GND | Package base / Ground |

Notes:

- The QPD1018 will be marked with the "QPD1018" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, the "MXXX" is the production lot number.

Package Dimensions^{1, 2, 3, 4}

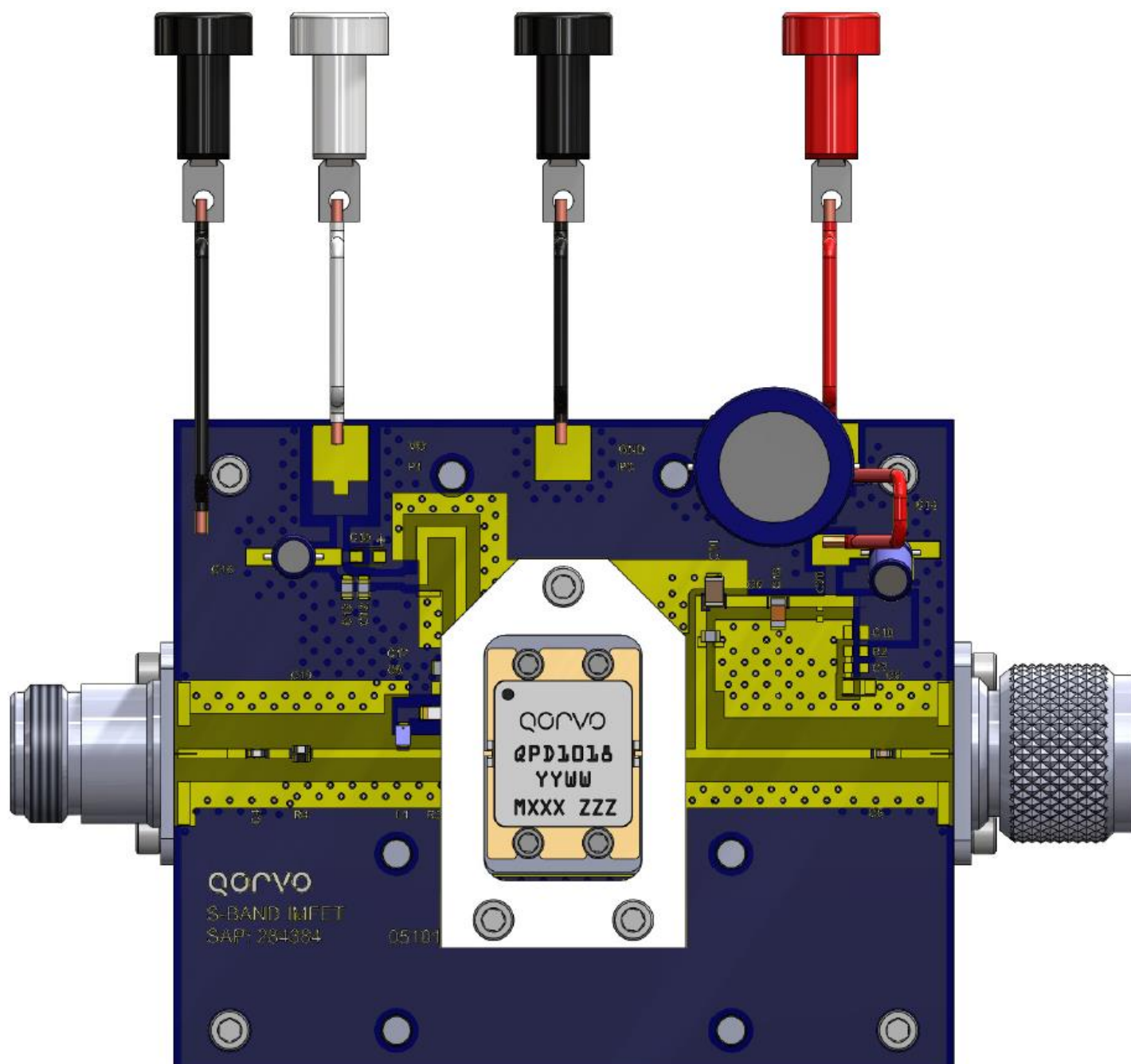


Notes:

1. All dimensions are in mm. otherwise noted, the tolerance is ± 0.15 mm.
2. Package is an all metal design with ceramic lid and feed thru's.
3. Package is epoxy sealed.
4. For instruction to mount the part, please refer to application note ["RF565 Package Mounting, Mechanical Mounting and PCB Considerations"](#).

| Bias-up Procedure | Bias-down Procedure |
|--|---|
| 1. Set V_G to -6 V. | 1. Turn off RF signal. |
| 2. Set I_D current limit to 1000 mA. | 2. Turn off V_D |
| 3. Apply 50 V V_D . | 3. Wait 2 seconds to allow drain capacitor to discharge |
| 4. Slowly adjust V_G until I_D is set to 750 mA. | 4. Turn off V_G |
| 5. Set I_D current limit to 2 A | |
| 6. Apply RF. | |

PCB Assembly – 2.7 – 3.1 GHz EVB¹



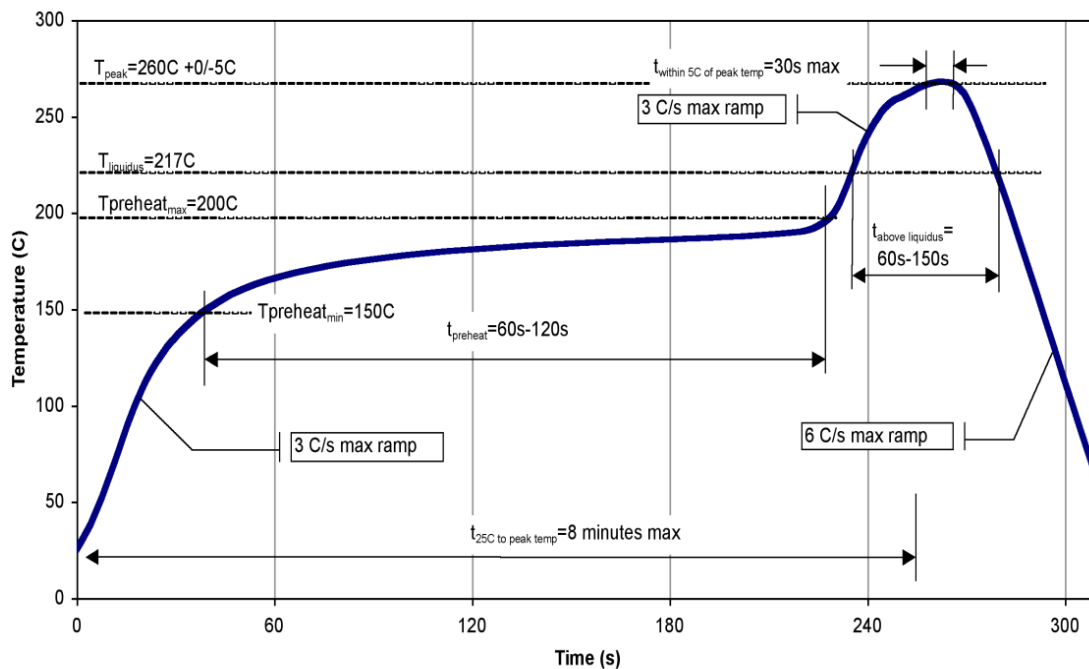
Notes:

1. PCB Material: RO4350B, 20 mil thickness, 1 oz copper cladding

Bill of Material – 2.7 – 3.1 GHz EVB

| Ref Des | Value | Qty | Manufacturer | Part Number |
|----------|----------|-----|--------------|--------------------|
| C1 | 680 uF | 1 | Panasonic | EEU-FC2A681 |
| C4, C19 | 10 pF | 2 | ATC | ATC600S100JW250XT |
| C5 | 15 pF | 1 | ATC | ATC600S150FT250XT |
| C6, C9 | 10 pF | 2 | ATC | ATC600F100BT250XT |
| C12 | 10000 pF | 1 | AVX/Kyocera | 08051C103KAZ2A |
| C11 | 0.1 uF | 1 | Murata | GRM32NR72A104KA01L |
| C13 | 0.1 uF | 1 | Kemet | C0805C104K5RACTU |
| C14, C16 | 10 uF | 2 | Panasonic | ECA-2AM100 |
| C17, C18 | 10000 pF | 2 | Samsung | CL31B103KGFNNNE |
| R3 | 10 Ohm | 1 | Panasonic | ERJ-8GEYJ100V |
| R4 | 1 kOhm | 1 | Vishay | CRCW06031K00FKTA |
| L1 | 22 nH | 1 | Coilcraft | 0805HT-22NTJLB |

Recommended Solder Temperature Profile



Handling Precautions

| Parameter | Rating | Standard |
|----------------------------------|----------|----------------------------|
| ESD – Human Body Model (HBM) | Class 2 | ANSI / ESDA / JEDEC JS-001 |
| ESD – Charged Device Model (CDM) | Class C3 | ANSI / ESDA / JEDEC JS-002 |
| MSL – Moisture Sensitivity Level | MSL 3 | IPC / JEDEC J-STD-020 |



Caution!
ESD-Sensitive Device

Solderability

Compatible with both lead-free (260°C max. reflow temp.) and tin/lead (245°C max. reflow temp.) soldering processes.

Solder profiles available upon request.

Contact plating: Ni/Au Au thickness is 1.0 µm.

RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Contact Information

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